October 2001



FDS6898AZ

Dual N-Channel Logic Level PWM Optimized PowerTrench[®] MOSFET

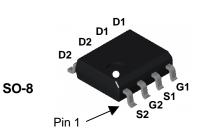
General Description

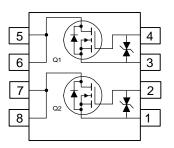
These N-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

Features

- 9.4 A, 20 V $\begin{array}{c} {\sf R}_{\sf DS(ON)} = {\sf 14} \mbox{ m}\Omega \ @ \ {\sf V}_{\sf GS} = {\sf 4.5} \ {\sf V} \\ {\sf R}_{\sf DS(ON)} = {\sf 18} \mbox{ m}\Omega \ @ \ {\sf V}_{\sf GS} = {\sf 2.5} \ {\sf V} \end{array}$
- Low gate charge (16 nC typical)
- ESD protection diode (note 3)
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability





12mm

Absolute Maximum Ratings T_A=25°C unless otherwise noted

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Symbol	Parameter			Ratings	Units	
V _{DSS}	Drain-Sour	ce Voltage		20	V	
V _{GSS}	Gate-Source Voltage			± 12		
I _D	Drain Curre	ent – Continuous	(Note 1a)	9.4	A	
		– Pulsed		38		
PD	Power Dissipation for Dual Operation			2	W	
	Power Diss	ipation for Single Operat	ion (Note 1a)	1.6		
			(Note 1b)	1		
			(Note 1c)	0.9		
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	
Therma	l Charac	teristics				
$R_{\theta JA}$	Thermal Re	esistance, Junction-to-Am	nbient (Note 1a)	78	°C/W	
$R_{\theta JC}$	Thermal Re	esistance, Junction-to-Ca	Se (Note 1)	40	°C/W	
Packag	e Markin	g and Ordering	Information		· · · ·	
Device Marking		Device	Reel Size	Tape width	Quantity	

13"

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2500 units

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	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	racteristics			L	I	L
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V$, $I_D = 250 \mu A$	20			V
<u>ΔBVdss</u> ΔTJ	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		21		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 16 \text{ V}, V_{\text{GS}} = 0 \text{ V}$			1	μΑ
I _{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 12 \text{ V}, V_{DS} = 0 \text{ V}$			10	μΑ
IGSSR	Gate-Body Leakage, Reverse	$V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$			-10	μΑ
On Cha	racteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_{D} = 250 \ \mu A$	0.5	1	1.5	V
$\Delta V_{GS(th)}$ ΔT_J	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		-3.5		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$ \begin{array}{l} V_{\rm GS} = 4.5 \ V, \ I_D = 9.4 \ A \\ V_{\rm GS} = 2.5 \ V, \ I_D = 8.3 \ A \\ V_{\rm GS} = 4.5 \ V, \ I_D = 9.4 \ A, T_J = 125^{\circ}C \end{array} $		10 13 14	14 18 21	mΩ
I _{D(on)}	On–State Drain Current	$V_{GS} = 4.5V, \qquad V_{DS} = 5 V$	19			Α
g FS	Forward Transconductance	$V_{DS} = 5 V$, $I_D = 9.4 A$		47		S
Dynami	c Characteristics					
Ciss	Input Capacitance	$V_{DS} = 10 V$, $V_{GS} = 0 V$,		1821		pF
Coss	Output Capacitance	f = 1.0 MHz		440		pF
C _{rss}	Reverse Transfer Capacitance			208		pF
Switchi	ng Characteristics (Note 2)					
t _{d(on)}	Turn–On Delay Time	$V_{DD} = 10 V$, $I_D = 1 A$,		10	20	ns
tr	Turn–On Rise Time	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$		15	27	ns
t _{d(off)}	Turn–Off Delay Time	7		34	55	ns
t _f	Turn–Off Fall Time	7		16	29	ns
Qg	Total Gate Charge	$V_{DS} = 10 \text{ V}, I_D = 9.4 \text{ A},$		16	23	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 4.5 V$		3		nC
Q _{gd}	Gate-Drain Charge			4		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings			•	
Is	Maximum Continuous Drain-Source				1.3	Α
-0	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \ V, I_S = 1.3 \ A$ (Note 2)		0.7	1.2	V

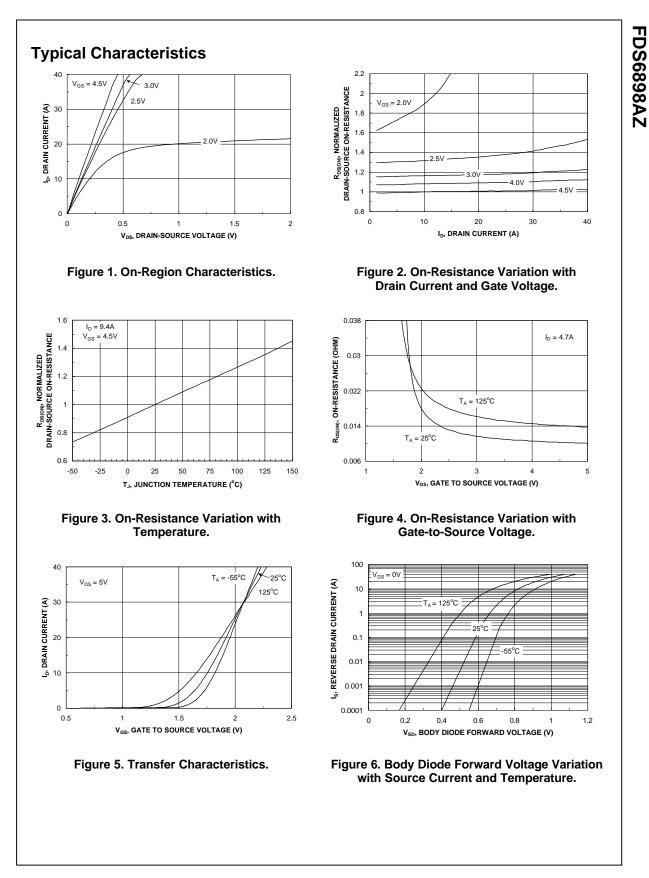


Scale 1 : 1 on letter size paper

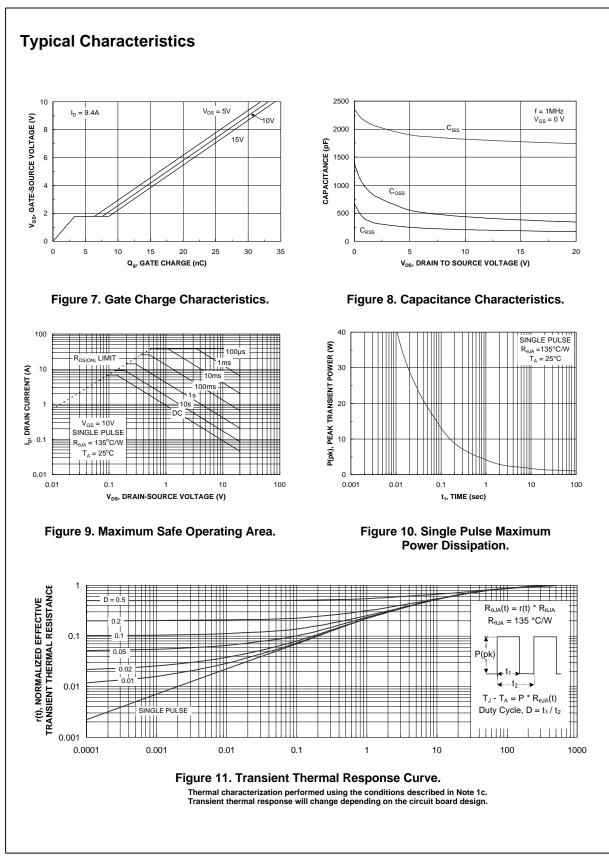
2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied

FDS6898AZ Rev C (W)



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